



# IMW120R045M1

CoolSiC<sup>™</sup> 1200V SiC Trench MOSFET Silicon Carbide MOSFET

#### Features

- Very low switching losses
- Threshold-free on state characteristic
- Wide gate-source voltage range
- Benchmark gate threshold voltage,  $V_{GS(th)} = 4.5V$
- 0V turn-off gate voltage
- Fully controllable dV/dt
- Commutation robust body diode, ready for synchronous rectification
- Temperature independent turn-off switching losses

### **Benefits**

- Efficiency improvement
- Enabling higher frequency
- Increased power density
- Cooling effort reduction
- Reduction of system complexity and cost

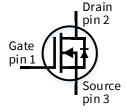
### **Potential applications**

- Energy generation
  - o Solar string inverter and solar optimizer
- Industrial power supplies
  - Industrial UPS
  - Industrial SMPS
- Infrastructure Charge
  - o Charger

### **Product validation**

Qualified for industrial applications according to the relevant tests of JEDEC 47/20/22

| Table 1 Ke   | able 1 Key Performance and Package Parameters |  |   |                |         |            |  |  |  |
|--------------|---|--|---|----------------|---------|------------|--|--|--|
| Туре         | V <sub>DS</sub>                               | I <sub>D</sub>   | <b>R</b> <sub>DS(on)</sub>                          | <b>T</b> j,max | Marking | Package    |  |  |  |
|              |   | $(T_{\rm C} = 25^{\circ}{\rm C}, R_{\rm th(j-c,max)})$ | $(T_{vj} = 25^{\circ}C, I_{D} = 20A, V_{GS} = 15V)$ |                |         |            |  |  |  |
| IMW120R045M1 | 1200V   | 52A  | 45mΩ  | 175°C          | 12M1045 | PG-TO247-3 |  |  |  |













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**Maximum ratings** 

## **1** Maximum ratings

For optimum lifetime and reliability, Infineon recommends operating conditions that do not exceed 80% of the maximum ratings stated in this datasheet.

#### Table 2 Maximum ratings

| Parameter   | Symbol  | Value             | Unit |
|---|---|-------------------|------|
| Drain-source voltage, <i>T<sub>vj</sub></i> ≥ 25°C  | V <sub>DSS</sub>  | 1200              | V    |
| DC drain current for $R_{\text{th(j-c,max)}}$ , limited by $T_{\text{vjmax}}$ , $V_{\text{GS}}$ = 15V,  |   |                   |      |
| <i>T</i> <sub>c</sub> = 25°C  | ID  | 52                | А    |
| $T_{\rm C} = 100^{\circ}{\rm C}$  |   | 36                |      |
| Pulsed drain current, $t_p$ limited by $T_{vjmax}$ , $V_{GS} = 15V$   | I <sub>D,pulse</sub> <sup>1</sup>                               | 130               | А    |
| DC body diode forward current for $R_{th(j-c,max)}$ ,<br>limited by $T_{vjmax}$ , $V_{GS} = 0V$<br>$T_c = 25^{\circ}C$<br>$T_c = 100^{\circ}C$      | I <sub>SD</sub>   | 52<br>28          | A    |
| Pulsed body diode current, $t_p$ limited by $T_{vjmax}$   | I <sub>SD,pulse</sub> <sup>1</sup>                              | 130               | А    |
| Gate-source voltage <sup>2</sup><br>Max transient voltage, < 1% duty cycle<br>Recommended turn-on gate voltage<br>Recommended turn-off gate voltage | V <sub>GSS</sub><br>V <sub>GSS,on</sub><br>V <sub>GSS,off</sub> | -10 20<br>15<br>0 | V    |
| Short-circuit withstand time<br>$V_{DD} = 800V, V_{DS,peak} < 1200V, V_{GS,on} = 15V, T_{j,start} = 25^{\circ}C$                                    | t <sub>sc</sub>   | 3                 | μs   |
| Power dissipation, limited by $T_{vjmax}$<br>$T_c = 25^{\circ}C$<br>$T_c = 100^{\circ}C$  | P <sub>tot</sub>  | 228<br>114        | W    |
| Virtual junction temperature  | T <sub>vj</sub>   | -55175            | °C   |
| Storage temperature   | T <sub>stg</sub>  | -55150            | °C   |
| Soldering temperature,<br>wavesoldering only allowed at leads,<br>1.6mm (0.063 in.) from case for 10 s  | $T_{sold}$  | 260               | °C   |
| Mounting torque, M3 screw<br>Maximum of mounting processes: 3   | М   | 0.6               | Nm   |

<sup>1</sup> verified by design

<sup>2</sup> **Important note:** The selection of positive and negative gate-source voltages impacts the long-term behavior of the device. The design guidelines described in <u>Application Note AN2018-09</u> must be considered to ensure sound operation of the device over the planned lifetime.

Thermal resistances



#### **Thermal resistances** 2

#### Table 3

| Parameter   | Sumbol               | Conditions | Value |      |      | Unit |
|---|----------------------|------------|-------|------|------|------|
|   | Symbol               |            | min.  | typ. | max. |      |
| MOSFET/body diode<br>thermal resistance,<br>junction – case | R <sub>th(j-c)</sub> |            | -     | 0.51 | 0.66 | K/W  |
| Thermal resistance,<br>junction – ambient                   | $R_{ m th(j-a)}$     | leaded     | -     | -    | 62   | K/W  |

IMW120R045M1 CoolSiC<sup>™</sup> 1200V SiC Trench MOSFET Electrical Characteristics



## 3 Electrical Characteristics

### 3.1 Static characteristics

#### Table 4Static characteristics (at $T_{vj}$ = 25°C, unless otherwise specified)

| Parameter                | Symbol                    | Conditions   | Value |      |      |    |
|--------------------------|---------------------------|--|-------|------|------|----|
|                          |                           |  | min.  | typ. | max. |    |
| Drain-source on-state    | R <sub>DS(on)</sub>       | $V_{\rm GS} = 15 V, I_{\rm D} = 20 A,$             |       |      |      | mΩ |
| resistance               |                           | <i>T</i> <sub>vj</sub> = 25°C                      | -     | 45   | 59   |    |
|                          |                           | <i>T</i> <sub>vj</sub> = 100°C                     | -     | 55   | -    |    |
|                          |                           | <i>T</i> <sub>νj</sub> = 175°C                     | -     | 75   | -    |    |
| Body diode forward       | $V_{\rm SD}$              | $V_{\rm GS} = 0V, I_{\rm SD} = 20A$                |       |      |      | V  |
| voltage                  |                           | <i>T</i> <sub>vj</sub> = 25°C                      | -     | 4.1  | 5.2  |    |
|                          |                           | <i>T</i> <sub>vj</sub> = 100°C                     | -     | 4.0  | -    |    |
|                          |                           | <i>T</i> <sub>νj</sub> = 175°C                     | -     | 3.9  | -    |    |
| Gate-source threshold    | $V_{\rm GS(th)}$          | (tested after 1 ms pulse at                        |       |      |      | V  |
| voltage                  |                           | $V_{\rm GS} = 20 \text{V}$                         |       |      |      |    |
|                          |                           | $I_{\rm D} = 10 {\rm mA}, V_{\rm DS} = V_{\rm GS}$ |       |      |      |    |
|                          |                           | <i>T</i> <sub>vj</sub> = 25°C                      | 3.5   | 4.5  | 5.7  |    |
|                          |                           | <i>T</i> <sub>νj</sub> =175°C                      | -     | 3.6  | -    |    |
| Zero gate voltage drain  | I <sub>DSS</sub>          | $V_{\rm GS} = 0$ V, $V_{\rm DS} = 1200$ V          |       |      |      | μA |
| current                  |                           | T <sub>vj</sub> =25°C                              | -     | 2    | 200  |    |
|                          |                           | <i>T</i> <sub>vj</sub> =175°C                      | -     | 4    | -    |    |
| Gate-source leakage      | I <sub>GSS</sub>          | $V_{\rm GS} = 20 V, V_{\rm DS} = 0 V$              | -     | -    | 120  | nA |
| current                  |                           | $V_{\rm GS} = -10 V, V_{\rm DS} = 0 V$             | -     | -    | -120 | nA |
| Transconductance         | $g_{fs}$                  | $V_{\rm DS} = 20 V, I_{\rm D} = 20 A$              | _     | 11.1 | -    | S  |
| Internal gate resistance | <b>R</b> <sub>G,int</sub> | $f = 1$ MHz, $V_{AC} = 25$ mV                      | -     | 4    | -    | Ω  |

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**Electrical Characteristics** 

### 3.2 Dynamic characteristics

#### Table 5Dynamic characteristics (at $T_{vj} = 25^{\circ}$ C, unless otherwise specified)

| Parameter             | Complex          | Constitution of  | Value |      |      | 11   |
|-----------------------|------------------|--|-------|------|------|------|
|                       | Symbol           | Conditions   | min.  | typ. | max. | Unit |
| Input capacitance     | Ciss             |  | -     | 1900 | -    |      |
| Output capacitance    | Coss             | $V_{DD} = 800V, V_{GS} = 0V,$<br>$f = 1MHz, V_{AC} = 25mV$         | -     | 115  | -    | рF   |
| Reverse capacitance   | Crss             |  | -     | 13   | -    |      |
| Coss stored energy    | E <sub>oss</sub> |  | -     | 44   | -    | μJ   |
| Total gate charge     | Q <sub>G</sub>   |  | -     | 52   | -    |      |
| Gate to source charge | $Q_{\rm GS,pl}$  | $V_{DD}$ = 800V, $I_{D}$ = 20A,<br>$V_{GS}$ = 0/15V, turn-on pulse | -     | 15   | -    | nC   |
| Gate to drain charge  | $Q_{\rm GD}$     | $v_{GS} = 0/15v$ , turn-on pulse                                   | -     | 13   | -    |      |

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**Electrical Characteristics** 



### 3.3 Switching characteristics

#### Table 6Switching characteristics, Inductive load 4

| Parameter                              | Symbol                        | Conditions  | Value |      |      | Unit |
|--|-------------------------------|---|-------|------|------|------|
|  |                               |   | min.  | typ. | max. |      |
| <b>MOSFET</b> Characteristics,         | <i>T</i> <sub>vj</sub> = 25°C |   |       |      |      |      |
| Turn-on delay time                     | $t_{ m d(on)}$                | $V_{\rm DD} = 800 \text{V}, I_{\rm D} = 20 \text{A},$   | -     | 9    | -    | ns   |
| Rise time                              | tr                            | $V_{\rm GS} = 0/15 V, R_{\rm G,ext} = 2\Omega,$   | -     | 24   | -    |      |
| Turn-off delay time                    | $t_{ m d(off)}$               | $L_{\sigma}$ = 40nH,  | -     | 17   | -    |      |
| Fall time                              | t <sub>f</sub>                | diode:  | -     | 13   | -    |      |
| Turn-on energy                         | Eon                           | body diode at $V_{GS} = 0V$   | -     | 350  | -    | μJ   |
| Turn-off energy                        | E <sub>off</sub>              | see Fig. E  | -     | 70   | -    |      |
| Total switching energy                 | E <sub>tot</sub>              |   | -     | 420  | -    |      |
| Body Diode Characteristi               | ics, $T_{vj} = 25^{\circ}C$   |   |       |      |      |      |
| Diode reverse recovery charge          | Qrr                           | $V_{DD} = 800V, I_{SD} = 20A,$<br>$V_{GS}$ at diode = 0V,   | -     | 0.15 | -    | μC   |
| Diode peak reverse<br>recovery current | / <sub>rrm</sub>              | d <i>i</i> <sub>f</sub> /d <i>t</i> = 1000A/μs,<br>Q <sub>rr</sub> includes also Q <sub>c</sub> ,<br>see Fig. C | -     | 8    | -    | A    |

| <b>MOSFET Characteristics</b> ,        | $T_{vj} = 175^{\circ}C$ | •   |   |      |   |    |
|--|-------------------------|---|---|------|---|----|
| Turn-on delay time                     | $t_{\rm d(on)}$         | $V_{\rm DD} = 800 \text{V}, I_{\rm D} = 20 \text{A},$   | - | 9    | - | ns |
| Rise time                              | tr                      | $V_{\rm GS} = 0/15 V, R_{\rm G,ext} = 2 \Omega,$  | - | 24   | - |    |
| Turn-off delay time                    | $t_{ m d(off)}$         | $L_{\sigma}$ = 40nH,  | - | 20   | - |    |
| Fall time                              | t <sub>f</sub>          | diode:  | - | 14   | - |    |
| Turn-on energy                         | $E_{on}$                | body diode at $V_{GS} = 0V$   | - | 380  | - | μJ |
| Turn-off energy                        | E <sub>off</sub>        | see Fig. E  | - | 75   | - |    |
| Total switching energy                 | $E_{\rm tot}$           |   | - | 455  | - |    |
| Body Diode Characteristi               | cs, $T_{vj} = 17$       | 5°C   |   |      |   |    |
| Diode reverse recovery charge          | Q <sub>rr</sub>         | $V_{DD} = 800V, I_{SD} = 20A,$<br>$V_{GS}$ at diode = 0V,                                       | - | 0.25 | - | μC |
| Diode peak reverse<br>recovery current | <i>I</i> <sub>rrm</sub> | di <sub>f</sub> /dt = 1000A/μs,<br>Q <sub>rr</sub> includes also Q <sub>c</sub> ,<br>see Fig. C | - | 10   | - | A  |

 $^4$  The chip technology was characterized up to 200 kV/µs. The measured dV/dt was limited by measurement test setup and package.

4



## Electrical characteristic diagrams

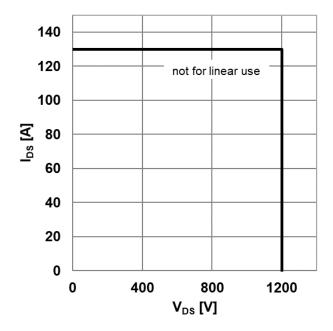


Figure 1 Reverse bias safe operating area (RBSOA) ( $V_{gs} = 0/15V$ ,  $T_c = 25^{\circ}C$ ,  $T_j < 175^{\circ}C$ )

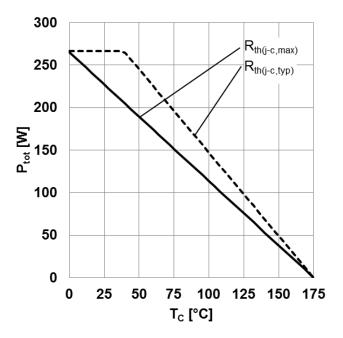
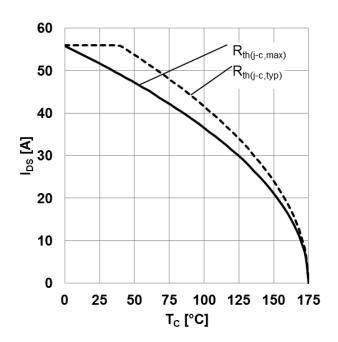


Figure 2 Power dissipation as a function of case temperature limited by bond wire  $(P_{tot} = f(T_c))$ 



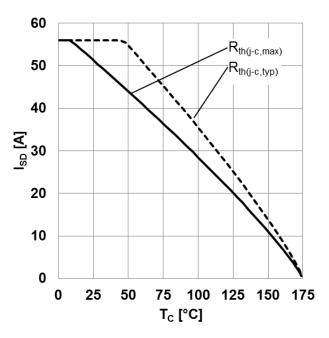
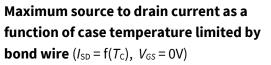
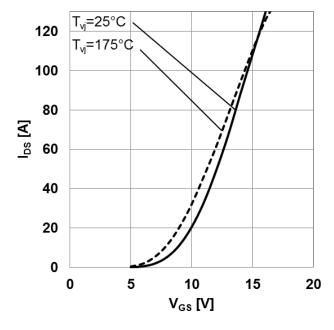
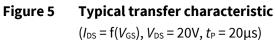


Figure 3 Maximum DC drain to source current as a Figure 4 function of case temperature limited by bond wire  $(I_{DS} = f(T_C))$ 









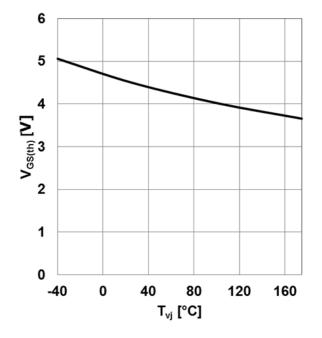


Figure 6 Typical gate-source threshold voltage as a function of junction temperature  $(V_{GS(th)} = f(T_{vj}), I_{DS} = 10 \text{ mA}, V_{GS} = V_{DS})$ 

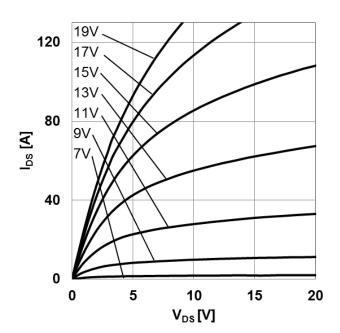


Figure 7 Typical output characteristic,  $V_{GS}$  as parameter ( $I_{DS} = f(V_{DS}), T_{vj}=25^{\circ}C, t_{P} = 20\mu s$ )

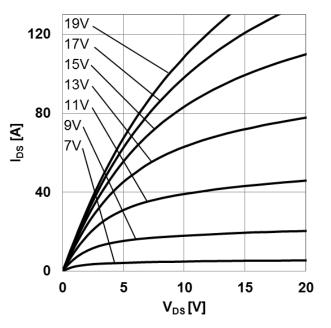
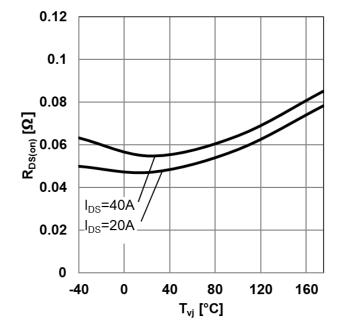
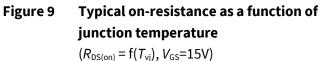
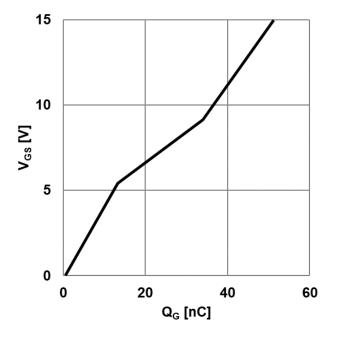


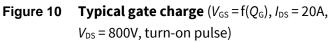
Figure 8 Typical output characteristic,  $V_{GS}$  as parameter ( $I_{DS} = f(V_{DS})$ ,  $T_{vj}=175^{\circ}C$ ,  $t_{P} = 20\mu s$ )

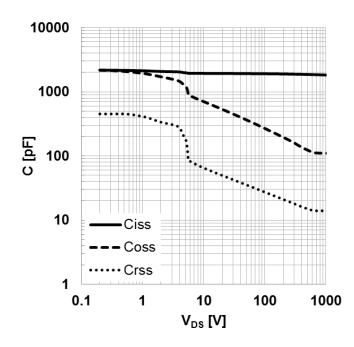


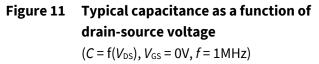












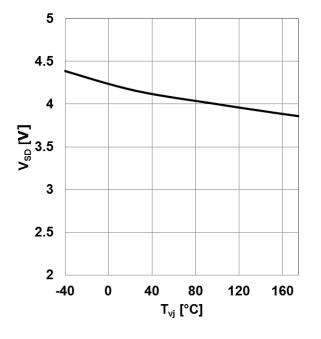


Figure 12 Typical body diode forward voltage as function of junction temperature  $(V_{SD}=f(T_{vj}), V_{GS}=0V, I_{SD}=20A)$ 



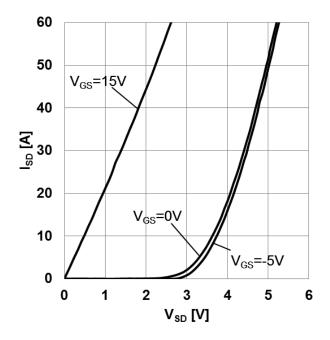
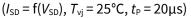


Figure 13 Typical body diode forward current as function of forward voltage, V<sub>GS</sub> as parameter



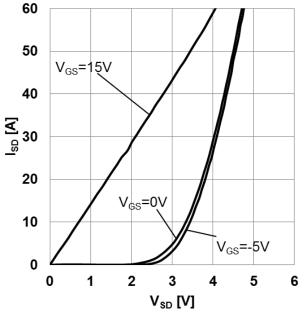
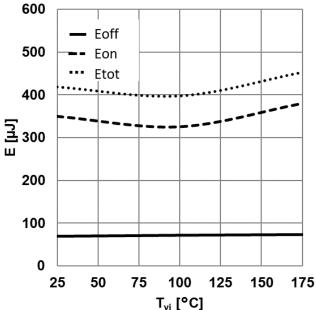


Figure 14 Typical body diode forward current as function of forward voltage,  $V_{GS}$  as parameter  $(I_{SD} = f(V_{SD}), T_{vj} = 175^{\circ}C, t_{P} = 20\mu s)$ 

Eoff



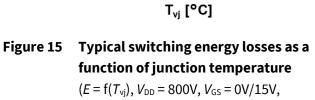
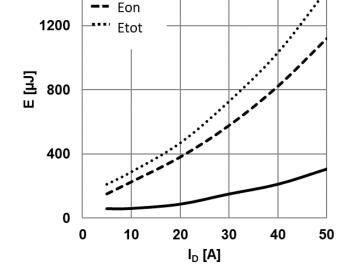
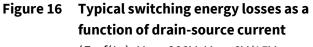


Fig. E, diode: body diode)

 $R_{G,ext} = 2\Omega$ ,  $I_D = 20A$ , ind. load, test circuit in

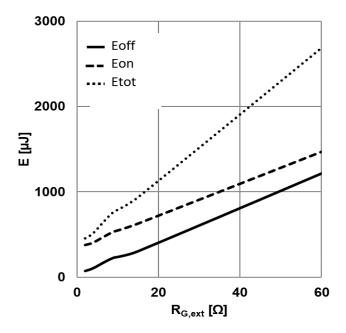


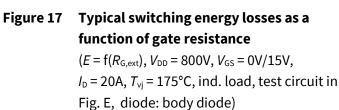


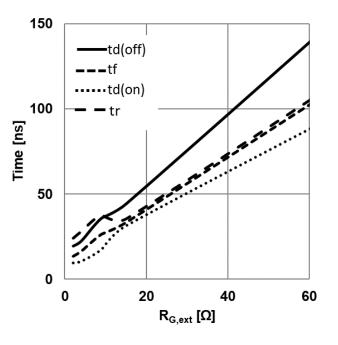
 $(E = f(I_{DS}), V_{DD} = 800V, V_{GS} = 0V/15V,$  $R_{G,ext} = 2\Omega, T_{vj} = 175^{\circ}C$ , ind. load, test circuit in Fig. E, diode: body diode)

1600



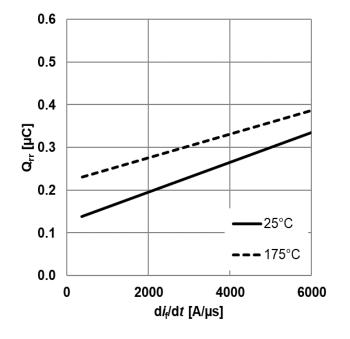


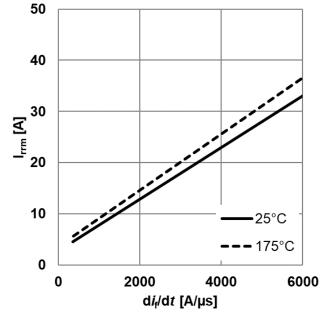






 $(t = f(R_{G,ext}), V_{DD} = 800V, V_{GS} = 0V/15V, I_D = 20A, T_{vj} = 175^{\circ}C$ , ind. load, test circuit in Fig. E, diode: body diode)





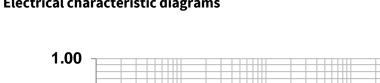
### Figure 19 Typical reverse recovery charge as a function of diode current slope $(Q_{rr} = f(di_f/dt), V_{DD} = 800V, I_D = 20A, ind. load,$

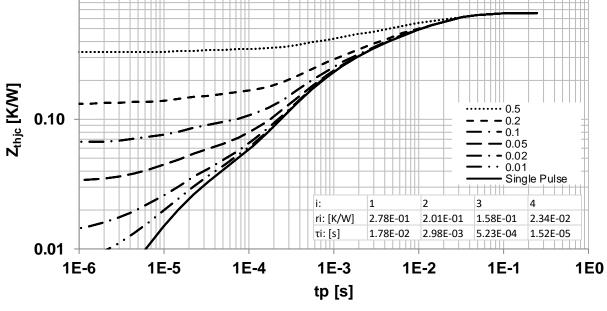
test circuit in Fig.E)

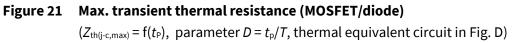
Figure 20 Typical reverse recovery current as a function of diode current slope

 $(I_{rrm} = f(di_f/dt), V_{DD} = 800V, I_D = 20A, ind. load, test circuit in Fig.E)$ 









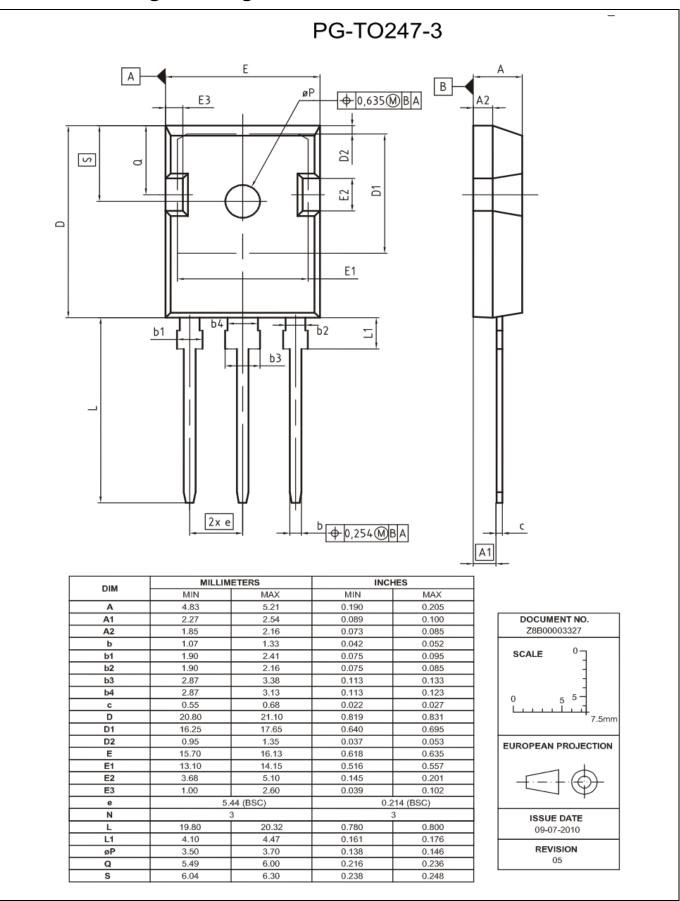
#### IMW120R045M1

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Package drawing







#### Figure 22 Package drawing

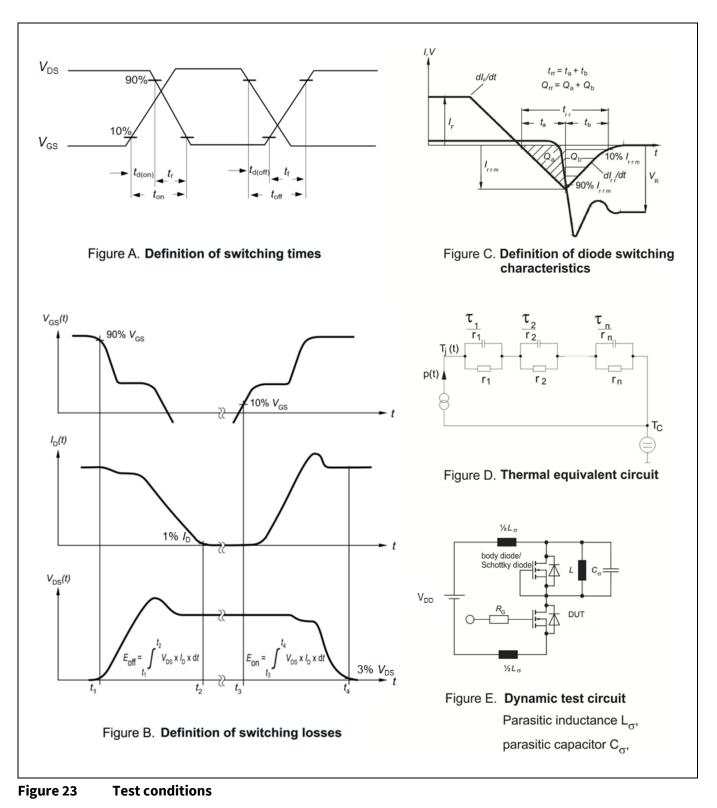
### IMW120R045M1 CoolSiC<sup>™</sup> 1200V SiC Trench MOSFET

**Test conditions** 

6



Test conditions





## **Revision history**

#### Major changes since the last revision

| Document<br>version | Date of release | Description of changes   |
|---------------------|-----------------|--|
| 2.1                 | 2018-03-01      | Initial version  |
| 2.2                 | 2018-05-30      | Important footnote update in chapter 1   |
|                     |                 | Change of conditions for switching dynamic characteristics in chapter 3.2 and 3.3              |
|                     |                 | Additional figures for V <sub>GS</sub> =0V/15V in chapter 4                                    |
| 2.3                 | 2019-04-18      | Add Recommended gate voltage in chapter 1  |
|                     |                 | Add SOA figure in chapter 4  |
|                     |                 | Figures removed for V <sub>GS</sub> =-5V/15V in chapter 4                                      |
| 2.4                 | 2019-12-10      | • Move the short circuit time from dynamic characteristics table 5 to maximum ratings table 2. |
|                     |                 | Update the Figure 21 Zth curve.  |

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